



PRODUCT DATA SHEET



To learn more about JGSEMI, please visit our website at







Datasheet

es Samples

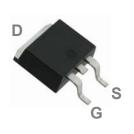
Please note: Please check the JINGAO Semiconductor website to verify the updated device numbers. The most current and up-to-date ordering information can be found at www.jg-semi.cn. Please email any questions regarding the system integration to JINGAO_questions@jgsemi.com.

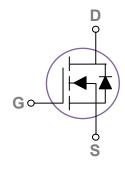


General Description

These N-Channel enhancement mode power field effect transistors are using trench DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency fast switching applications.

TO252 Pir	Configuration
------------------	---------------





BVDSS	RDSON	ID
30V	4m $Ω$	90A

Features

- 30V, 90A, RDS(ON) = $4m\Omega@VGS = 10V$
- Improved dv/dt capability
- Fast switching
- 100% EAS Guaranteed
- Green Device Available

Applications

- MB / VGA / Vcore
- POL Applications
- SMPS 2nd SR

Absolute Maximum Ratings Tc=25℃ unless otherwise noted

Symbol	Parameter	Rating	Units
V_{DS}	Drain-Source Voltage	30	V
V_{GS}	Gate-Source Voltage	±20	V
_	Drain Current – Continuous (T _C =25°C)	90	Α
lD	Drain Current – Continuous (T _C =100°C)	57	А
I _{DM}	Drain Current – Pulsed ¹	360	Α
EAS	Single Pulse Avalanche Energy ²	125	mJ
IAS	Single Pulse Avalanche Current ²	50	А
D	Power Dissipation (T _C =25°C)	88	W
P _D	Power Dissipation – Derate above 25°C	0.59	W/°C
T _{STG}	Storage Temperature Range	-55 to 175	°C
TJ	Operating Junction Temperature Range	-55 to 175	°C

Thermal Characteristics

Symbol	nbol Parameter		Max.	Unit
$R_{\theta JA}$	Thermal Resistance Junction to ambient		62	°C/W
$R_{\theta JC}$	Thermal Resistance Junction to Case		1.7	°C/W



Electrical Characteristics (T_J=25 °C, unless otherwise noted) **Static State Characteristics**

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BV_{DSS}	Drain-Source Breakdown Voltage	V_{GS} =0V , I_D =250uA	30			V
$\triangle BV_{DSS}/\triangle T_{J}$	BV _{DSS} Temperature Coefficient	Reference to 25°C , I _D =1mA		0.03		V/°C
	Drain-Source Leakage Current	V_{DS} =30V , V_{GS} =0V , T_J =25 $^{\circ}$ C			1	uA
I _{DSS}		V_{DS} =24V , V_{GS} =0V , T_J =125 $^{\circ}$ C			10	uA
I_{GSS}	Gate-Source Leakage Current	V_{GS} = $\pm 20V$, V_{DS} = $0V$			±100	nA
D	Static Drain-Source On-Resistance ³	V_{GS} =10V , I_D =24A		3.1	4	mΩ
R _{DS(ON)}	Static Drain-Source On-Resistance	V_{GS} =4.5 V , I_D =12 A		4.5	6	mΩ
$V_{GS(th)}$	Gate Threshold Voltage	V V I 050-A		1.6	2.5	V
$ riangle V_{GS(th)}$	V _{GS(th)} Temperature Coefficient	$V_{GS}=V_{DS}$, $I_D=250uA$		-5		mV/°C
gfs	Forward Transconductance	V _{DS} =10V , I _D =10A		15.5		S

Dynamic Characteristics

Qg	Total Gate Charge ^{3, 4}			24	36	
Q_{gs}	Gate-Source Charge ^{3, 4}	V_{DS} =15V , V_{GS} =4.5V , I_{D} =24A		4.2	8	nC
Q_{gd}	Gate-Drain Charge ^{3, 4}			13	20	
$T_{d(on)}$	Turn-On Delay Time ^{3 , 4}			12.6	24	
Tr	Rise Time ^{3, 4}	V_{DD} =15V , V_{GS} =10V , R_{G} =3.3 Ω		19.5	37	20
T _{d(off)}	Turn-Off Delay Time ^{3, 4}	I _D =15A		42.8	81	ns
T _f	Fall Time ^{3, 4}			13.2	25	
C _{iss}	Input Capacitance			2200	3300	
Coss	Output Capacitance	V_{DS} =25V , V_{GS} =0V , F=1MHz		280	410	pF
C _{rss}	Reverse Transfer Capacitance			177	260	
R_g	Gate resistance	V _{GS} =0V, V _{DS} =0V, F=1MHz		2	4	Ω

Guaranteed Avalanche Energy

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
EAS	Single Pulse Avalanche Energy	V _{DD} =25V, L=0.1mH, IAS=24A	31			mJ

Drain-Source Diode Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Is	Continuous Source Current	V =V =0V Force Current			90	Α
I _{SM}	Pulsed Source Current ³	V _G =V _D =0V , Force Current			180	Α
V_{SD}	Diode Forward Voltage ³	V _{GS} =0V , I _S =1A , T _J =25°C		0.7	1	V

Note:

- 1. Repetitive Rating : Pulsed width limited by maximum junction temperature.
- 2. V_{DD} =25V, V_{GS} =10V,L=0.1mH, I_{AS} =50A., R_G =25 Ω , Starting T_J =25 $^{\circ}$ C.
- 3. The data tested by pulsed , pulse width \leq 300us , duty cycle \leq 2%.
- 4. Essentially independent of operating temperature.



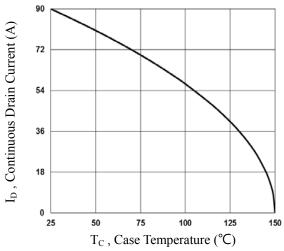


Fig.1 Continuous Drain Current vs. T_c

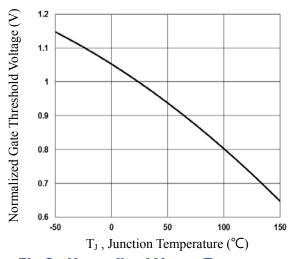


Fig.3 Normalized V_{th} vs. T_J

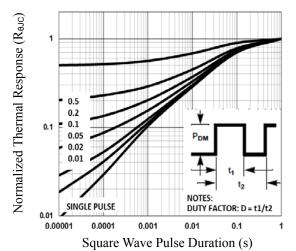


Fig.5 Normalized Transient Impedance

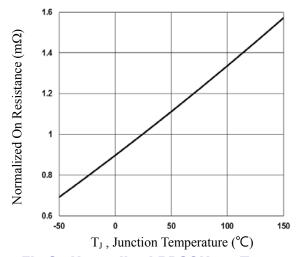


Fig.2 Normalized RDSON vs. T,

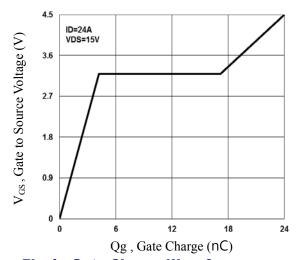


Fig.4 Gate Charge Waveform

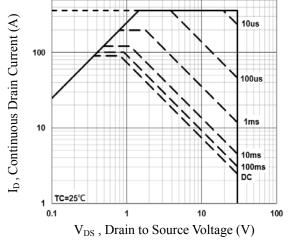


Fig.6 Maximum Safe Operation Area

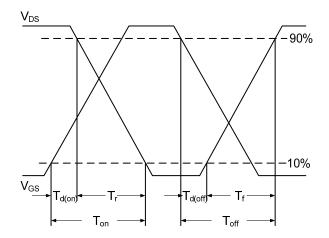


Fig.7 Switching Time Waveform

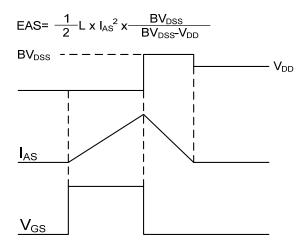
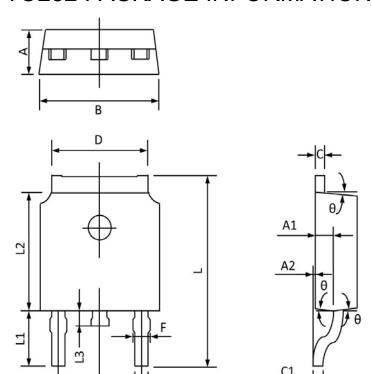


Fig.8 EAS Waveform



TO252 PACKAGE INFORMATION



Cross had	Dimensions I	Dimensions In Millimeters		s In Inches
Symbol	MAX	MIN	MAX	MIN
A	2.400	2.200	0.094	0.087
A1	1.110	0.910	0.044	0.036
A2	0.150	0.000	0.006	0.000
В	6.800	6.400	0.268	0.252
C	0.580	0.450	0.023	0.018
C1	0.580	0.460	0.023	0.018
D	5.500	5.100	0.217	0.201
E	2.386	2.186	0.094	0.086
\mathbf{F}	0.940	0.600	0.037	0.024
F1	0.860	0.500	0.034	0.020
L	10.400	9.400	0.409	0.370
L1	3.000	2.400	0.118	0.094
L2	6.200	5.400	0.244	0.213
L3	1.200	0.600	0.047	0.024
θ	9°	3°	9°	3°



Attention

- 1, Any and all JGSEMI products described or contained herein do not have specifications that can handle applications that require extremely high levels of reliability, such as life-support systems, aircraft's control systems, orother applic ations whose failure can be reasonably expected to result in serious physical or material damage. Consult with your JGSEMI representative nearest you before using any JGSEMI products described or contained herein in such applications.
- 2,JGSEMI assumes no responsibility for equipment failures that result from using products at values that exceed, even momentarily, rated values (such as maximum ratings, operating condition ranges, or other parameters) listed in products specifications of any and all JGSEMI products described or contained herein.
- 3, Specifications of any and all JGSEMI products described or contained herein stipulate the performance, characteristics, and functions of the described products in the independent state, and are not guarantees of the performance, characteristics, and functions of the described products as mounted in the customer's products or equipment. To ver ify symptoms and states that cannot be evaluated in an independent device, the customer should always evaluate and test devices mounted in the customer's products or equipment.
- 4,In the event that any or all JGSEMI products (including technical data, services) described or contained herein are controlled under any of applicable local export control laws and regulations, such products must not be exported wit hout obtaining the export license from the authorities concerned in accordance with the above law.
- 5, No part of this publication may be reproduced or transmitted in any form or by any means, electronic or mechanic al, including photocopying and recording, or any information storage or retrieval system, or otherwise, without the pr ior written permission of JGSEMI Semiconductor CO., LTD.
- 6, Any and all information described or contained herein are subject to change without notice due to product technology improvement, etc. When designing equipment, refer to the "Delivery Specification" for the JGSEMI product that you Intend to use.